

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10822064	MEYER ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
/Chang, Rick K	3726	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
29	832,834	11/25/07	rc
257	737,738,778,723		
438	108,115,118,666		
	search updated	2/16/09	

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
east search	11/25/07	rc
	2/16/09	rc

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>